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Application/Control No.	Applicant(s)/Patent under Reexamination	. (
10/738,459	TOUR ET AL.	
Examiner	Art Unit	
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SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Search	9/22/2005	EW
EAST	9/22/2006	EW
STN	9/22/2005	EW
Search Updated	3/17/2006	EW /
Google Scholar Search on James Tour	3/17/2006	EW
IEEE Search	3/17/2006	EW /
Search Updated	9/9/2006	EW